

This certificate is granted and awarded by the authority of the Nadcap Management Council to:

TANIDA LTD.

28-2, Ra, Higashikagatsume-machi, Kanazawa-shi, Ishikawa-ken, 920-0209 Japan

This certificate demonstrates conformance and recognition of accreditation for specific services, as listed in www.eAuditNet.com on the Qualified Manufacturers List (QML), to the revision in effect at the time of the audit for:

NonDestructive Testing

Certificate Number: 11582203325 Expiration Date: 31 May 2024 Accreditation Length: 24 Months

Jay Solomond

Executive Vice President & Chief Operating Officer



SCOPE OF ACCREDITATION

NonDestructive Testing

TANIDA LTD.

28-2, Ra, Higashikagatsume-machi, Kanazawa-shi, Ishikawa-ken, 920-0209 Japan

This certificate expiration is updated based on periodic audits. The current expiration date and scope of accreditation are listed at: www.eAuditNet.com - Online QML (Qualified Manufacturer Listing).

In recognition of the successful completion of the PRI evaluation process, accreditation is granted to this facility to perform the following:

AC7000 - AUDIT CRITERIA FOR NADCAP ACCREDITATION

AC7108/2 Rev G - Nadcap Audit Criteria for Etch Inspection Processes (Anodic Etch, Blue Etch Anodize, Macrostructure, Nital/Temper) – Download checklist from Chem Processing (to be used on audits BEFORE 12-Jun-2022)

Pre-Penetrant Etch Immersion pre

AC7114 Rev P - Nadcap Audit Criteria for NonDestructive Testing (NDT) Auditees Accreditation Program (to be used on audits BEFORE 10-Jul-2022)

AC7114S Rev O - Nadcap Supplemental Audit Criteria for NonDestructive Testing (NDT)

Auditees Accreditation Program (to be used on audits BEFORE 19-Jun-2022)

S-U1 Honeywell

S-U10 GE Aviation

S-U14 SAFRAN

AC7114/1 Rev N - Nadcap Audit Criteria for NonDestructive Testing Facility Penetrant Survey (to be used on/after 02 May 2021)

AC7114/1S Rev O - Nadcap Supplemental Audit Criteria for NonDestructive Testing Facility Penetrant Survey (to be used on audits on/AFTER 12-Dec-2021)

S-U1 Honeywell

S-U14 SAFRAN

AC7114/10 Rev B - Nadcap Audit Criteria for NonDestructive Testing Facility Digital
Radiography, Utilizing Digital Detector Array (DDA) & Computed Radiography (CR) Utilizing
Photostimulable Luminescence (PSL) Survey (to be used on/after 02 May 2021)

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Kanazawa-shi, Ishikawa-ken, Japan

CR DDA

AC7114/10S Rev A - Nadcap Supplemental Audit Criteria for NonDestructive Testing Facility
Digital Radiography, Utilizing Digital Detector Array (DDA)&Computed Radiography (CR)
Utilizing Photostimulable Luminescence (PSL) Survey(to be used on audits on/AFTER 12-Dec2021

S-U1 Honeywell S-U10 GE Aviation S-U14 SAFRAN

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